Se	arch	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination
10/646,555	LEE ET AL.
Examiner	Art Unit
Charles Kim	2624

	SEARCHED		
Class	Subclass	Date	Examiner
-			

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
701/200-302; 382/104,107,181-231; 348/113-119 - text search (see search history report)	3/27/2007	ск
Inventor Name Search	3/27/2007	ск
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